DELIVERY SPECIFICATION

SPEC. No. C-150C-f

D A T E: Oct., 2021

То

Non-Controlled Copy

CUSTOMER'S PRODUCT NAME

Multilayer Ceramic Chip Capacitors
(Guaranteed at High Temperature)

Bulk and tape packaging [RoHS compliant]

C1005,C1608,C2012,C3216,C3225,C4532,C5750 Type

NP0,X8R,X8L Characteristics

Please return this specification to TDK representatives with your signature. If orders are placed without returned specification, please allow us to judge that specification is accepted by your side.

RECEIPT CONFIRMATION

DATE: YEAR MONTH DAY

TDK Corporation Sales Electronic Components Sales & Marketing Group

Engineering

Electronic Components Business Company Ceramic Capacitors Business Group

APPROVED	Person in charge

APPROVED	CHECKED	Person in charge

SCOPE

This delivery specification shall be applied to chip type multilayer ceramic capacitors to be delivered to

PRODUCTION PLACES

Production places defined in this specification shall be TDK Corporation, TDK(Suzhou)Co.,Ltd and TDK Components U.S.A.,Inc.

PRODUCT NAME

The name of the product to be defined in this specifications shall be $\underline{C} \Diamond \Diamond \Diamond \Diamond O O \triangle \triangle \Box \Box \Box \times$.

REFERENCE STANDARD

JIS C 5101-1:2010	Fixed capacitors for use in electronic equipment-Part 1: Generic specification
C 5101-21:2014	Fixed capacitors for use in electronic equipment-Part 21 : Sectional specification
	: Fixed surface mount multilayer capacitors of ceramic dielectric, Class1
C 5101-22:2014	Fixed capacitors for use in electronic equipment-Part 22 : Sectional specification
	: Fixed surface mount multilayer capacitors of ceramic dielectric, Class2
C 0806-3:2014	Packaging of components for automatic handling - Part 3: Packaging of
	surface mount components on continuous tapes
JEITA RCR-2335 C 2014	Safety application guide for fixed ceramic capacitors for use in electronic
	equipment

CONTENTS

- 1. CODE CONSTRUCTION
- 2. COMBINATION OF RATED CAPACITANCE AND TOLERANCE
- 3. OPERATING TEMPERATURE RANGE
- 4. STORING CONDITION AND TERM
- 5. P.C. BOARD
- 6. INDUSTRIAL WASTE DISPOSAL
- 7. PERFORMANCE
- 8. INSIDE STRUCTURE AND MATERIAL
- 9. PACKAGING
- 10. RECOMMENDATION
- 11. SOLDERING CONDITION
- 12. CAUTION
- 13. TAPE PACKAGING SPECIFICATION

<EXPLANATORY NOTE>

When the mistrust in the spec arises, this specification is given priority. And it will be confirmed by written spec change after conference of both posts involved.

This specification warrants the quality of the ceramic chip capacitor. Capacitors should be evaluated or confirmed a state of mounted on your product.

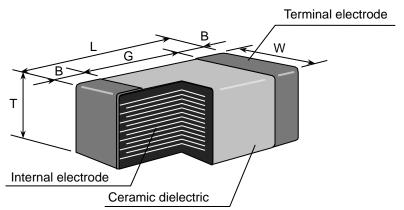
If the use of the capacitors goes beyond the bounds of this specification, we can not afford to guarantee.

Division	Date	SPEC. No.		
Ceramic Capacitors Business Group	October., 2021	C-150C-f		

1. CODE CONSTRUCTION

(Example) <u>C1005</u> <u>X8R</u> <u>1E</u> <u>103</u> <u>K</u> <u>T</u> <u>OOOO</u> (1) (2) (3) (4) (5) (6) (7)

(1) Case size



Case size		Dimer	nsions (Unit : mm)		
[EIA style]	L	L W T		В	G	
C1005	1.00±0.05	0.50±0.05	0.50±0.05	0.40 min	0.30 min.	
[CC0402]	1.00±0.10	0.50±0.10	0.50±0.10	0.10 min.		
	1.60±0.10	0.80±0.10	0.80±0.10			
C1608 [CC0603]	1.60±0.15	0.80±0.15	0.80±0.15	0.20 min.	0.30 min.	
[88888]	1.60±0.20	0.80±0.20	0.80±0.20			
			0.60±0.15			
C2012	2.00±0.20	1.25±0.20	0.85±0.15		0.50 min.	
[CC0805]			1.25±0.20	0.20 min.		
	2.00 ^{+0.25} - 0.15	1.25 ^{+0.25} - 0.15	1.25 ^{+0.25} - 0.15			
	3.20±0.20	1.60±0.20	0.60±0.15		1.00 min.	
			0.85±0.15	0.20 min.		
C3216			1.15±0.15			
[CC1206]			1.60±0.20			
	3.20 ^{+0.30} - 0.10	1.60 ^{+0.30} - 0.10	1.60 ^{+0.30} - 0.10			
			1.25±0.20			
			1.60±0.20			
C3225 [CC1210]	3.20±0.40	2.50±0.30	2.00±0.20	0.20 min.		
[00:2:0]			2.30±0.20			
			2.50±0.30			
			2.00±0.20			
C4532 [CC1812]	4.50±0.40	3.20±0.40	2.30±0.20	0.20 min.		
			3.20±0.30			
C5750	5.70±0.40	5.00±0.40	2.30±0.20	0.20 min.		
[CC2220]	5.70±0.40	5.00±0.40	2.80±0.30	0.20 111111.		

^{*} As for each item, please refer to detail page on TDK web.

(2) Temperature Characteristics

* Details are shown in table 1 No.6 and No.7 at 7.PERFORMANCE

(3) Rated Voltage

Symbol	Rated Voltage	Symbol	Rated Voltage
2 J	DC 630 V	1 E	DC 25 V
2 W	DC 450 V	1 C	DC 16 V
2 E	DC 250 V	1 A	DC 10 V
2 A	DC 100 V	0 J	DC 6.3 V
1 H	DC 50 V	0 G	DC 4V

(4) Rated Capacitance

Stated in three digits and in units of pico farads (pF). The first and Second digits identify the first and second significant figures of the capacitance, the third digit identifies the multiplier.

(Example)	
Curanhani	Rated

Symbol	Rated Capacitance
103	10,000 pF

(5) Capacitance tolerance

Symbol	Tolerance	Capacitance
С	± 0.25 pF	10pE and under
D	± 0.5 pF	10pF and under
J	± 5%	
K	± 10 %	Over 10pF
М	± 20 %	

(6) Packaging

* C1005 type is applicable to tape packaging only.

Symbol	Packaging
В	Bulk
Т	Taping

(7) TDK internal code

2. COMBINATION OF RATED CAPACITANCE AND TOLERANCE

Class	Temperature Characteristics	Capacitano	e tolerance	Rated capacitance	
		10pF and under	C (± 0.25pF)	1, 2, 3, 4, 5	
1	1 NP0	Topr and under	D (± 0.5pF)	6, 7, 8, 9, 10	
		Over 10pF	J (± 5%)	E – 6 series E – 12 series	
2	X8R X8L	K (± 10 %)	M (± 20 %)	E – 6 series	

Capacitance Step in E series

E series	Capacitance Step											
E- 6	1.0 1.5 2.2 3.3 4.7 6.8						.8					
E-12	1.0	1.2	1.5	1.8	2.2	2.7	3.3	3.9	4.7	5.6	6.8	8.2

3. OPERATING TEMPERATURE RANGE

Min. operating	Max. operating	Reference
Temperature	Temperature	Temperature
-55°C	150°C	25°C

4. STORING CONDITION AND TERM

Storing temperature	Storing humidity	Storing term
5~40°C	20~70%RH	Within 6 months upon receipt.

5. P.C. BOARD

When mounting on an aluminum substrate, the capacitors are more likely to be affected by heat stress from the substrate.

Please inquire separate specification when mounted on the substrate.

6. INDUSTRIAL WASTE DISPOSAL

Dispose this product as industrial waste in accordance with the Industrial Waste Law.

7. PERFORMANCE

table 1

No.	Item	Performance		Test o	r inspectio	n m	nethod
1	External Appearance	No defects which may affect performance.	Inspect with magnifying glass (3x)			s (3x)	
2	Insulation Resistance	10,000MΩ or 500MΩ·μF min. (As for the capacitors of rated voltage 16V DC and lower, 100MΩ·μF min.)	capacitors of rated voltage (As for the capacitor of rated			ed voltage	
3	Voltage Proof	Withstand test voltage without insulation breakdown or other	Class	volta	ated age(RV)		Apply voltage
		damage.			≦100V		× rated voltage
			1		(RV≦500V		5 × rated voltage
							3 × rated voltage 5 × rated voltage
			2 RV≦100V 2.5 x rated voltage Voltage application time : 1s. Charge / discharge current : 50mA or lower				
4	Capacitance	Within the specified tolerance.	《Class	1》			
			Capac	itance	Measurin frequenc		Measuring voltage
			1000pF and under		1MHz±10	%	0.5 ~ 5 Vrms.
			Over 1000pF 1kHz±10%		%		
			《Class 2》				
			Capac	itance	Measurin frequenc	_	Measuring voltage
				and der	1kHz±109	%	1.0±0.2Vrms
			Over	10uF	120Hz±20	%	0.5±0.2Vrms.
5	Q (Class1)	Please refer to detail page on TDK web.	See No.		s table for	me	asuring
	Dissipation Factor (Class2)						

(contir	nued)		
No.	Item	Performance	Test or inspection method
6	Temperature Characteristics of Capacitance (Class1)	T.C. Temperature Coefficient (ppm/°C) NP0 0 ± 30 Capacitance Within ± 0.2% or ± 0.05pF, whichever larger.	Temperature coefficient shall be calculated based on values at 25°C and 85°C temperature. Measuring temperature below 25°C shall be -10°C and -25°C.
7	Temperature Characteristics of Capacitance (Class2)	Capacitance Change (%) No voltage applied X8R: ±15 X8L: +15 - 40	Capacitance shall be measured by the steps shown in the following table after thermal equilibrium is obtained for each step. ΔC be calculated ref. STEP3 reading $\frac{\text{Step}}{1}$ $\frac{\text{Temperature}(^{\circ}\text{C})}{2}$ $\frac{25 \pm 2}{4}$ $\frac{25 \pm 2}{4}$ $\frac{150 \pm 2}{4}$ As for measuring voltage, please contact with our sales representative.
8	Robustness of Terminations	No sign of termination coming off, breakage of ceramic, or other abnormal signs.	Reflow solder the capacitors on a P.C.Board shown in Appendix2. Apply a pushing force gradually at the center of a specimen in a horizontal direction of P.C.board. Pushing force: 5N (2N is applied for C1005 type.) Holding time: 10±1s Pushing force P.C.Board
9	Bending	No mechanical damage.	Reflow solder the capacitors on a P.C.Board shown in Appendix1 and bend it for 1mm.

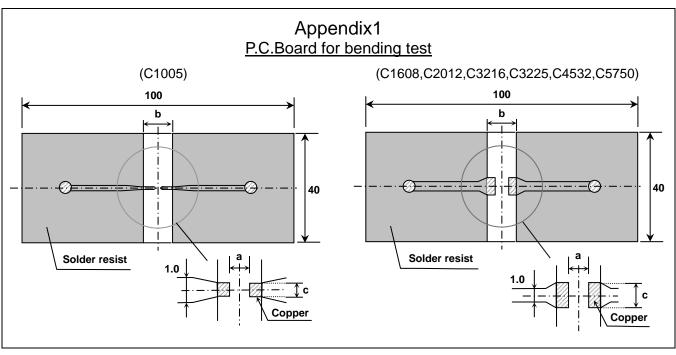
No.	Ite	em		Perf	ormance	Test o	r inspection method
10	0 Solderability		New solder to cover over 75% of termination. 25% may have pin holes or rough spots but not concentrated in one spot. Ceramic surface of A sections shall not be exposed due to melting or shifting of termination material. A section			Solder: Flux: Solder temp.: Dwell time: Solder position:	Sn-3.0Ag-0.5Cu Isopropyl alcohol (JIS K 8839) Rosin (JIS K 5902) 25% solid solution. 245±5°C 3±0.3s. Until both terminations are completely soaked.
11	Resistance to solder heat	External appearance Capacitance	terminatio	ns sha	llowed and all be covered at new solder.	Solder : Flux :	Sn-3.0Ag-0.5Cu Isopropyl alcohol (JIS K 8839) Rosin (JIS K 5902) 25% solid solution.
		Capacitario	Characte	eristics	Change from the value before test Capacitance drift	Solder temp. : Dwell time : Solder position : Pre-heating :	260±5°C 10±1s.
			Class1 Class2	NP0 X8R X8L	within ±2.5% or ±0.25pF, whichever larger. ±7.5 %		Until both terminations are completely soaked. Temp. — 110~140°C
		Q (Class1)	Meet the	eet the initial spec.			Time — $30\sim$ 60s.
		D.F. (Class2)	Meet the initial spec.			condition for Class 1 : 6~24 Class 2 : 24±2	4h 2h before measurement.
		Insulation Resistance	Meet the	initial s	pec.		
		Voltage proof	No insula damage.	tion bre	eakdown or other		

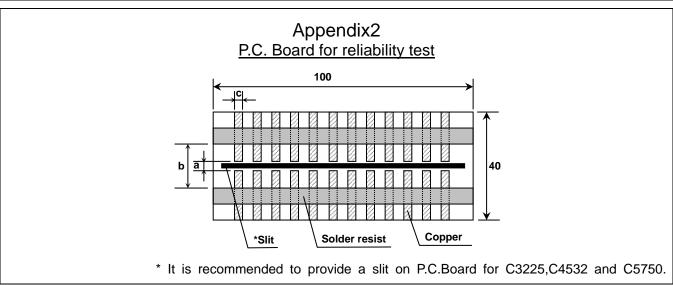
No.	Ite	em		Per	formance	7	Test or inspection method			
12	Vibration	External appearance Capacitance	No mech	anical		Recipro Amplitu	Frequency: 10~55~10Hz Reciprocating sweep time: 1 min. Amplitude: 1.5mm Repeat this for 2h each in 3 perpendicular directions(Total 6h). Reflow solder the capacitors on a P.C.Board shown in Appendix2 before			
			Class1 Class2	NP0 X8R X8L	Change from the value before test ±2.5% or ±0.25pF, whichever larger. ±7.5 %	Reflow P.C.Box				
		Q (Class1) D.F. (Class2)	Meet the			tosung.	testing.			
13	Temperature cycle	External appearance	No mechanical damage.			step1 th	Expose the capacitors in the condition step1 through step 4 listed in the following table. Temp. cycle: 5 cycles			
		Characteristics value before test	L'haracteristics i		Temp. o					
						Step	Temperature(°C)	Time (min.)		
			Class1	_	with our sales	1	-55 ± 3	30 ± 3		
			2	Ambient Temp.	2 ~ 5					
		Q	Meet the	initial	spec.	3	150 ± 2	30 ± 2		
		(Class1)			•	4	Ambient Temp.	2 ~ 5		
		D.F. (Class2)	Meet the	initial	spec.	condition	Leave the capacitors in ambient condition for Class 1 : 6~24h			
		Insulation Resistance	Meet the initial spec.		Class 2 Reflow	: 24±2h before m solder the capacit	ors on a			
		Voltage proof	No insula damage.		eakdown or other		P.C.Board shown in Appendix2 before			

No.	It	em	Perfo	rmance	Test or inspection method	
14	Moisture Resistance	External appearance	No mechanical da	amage.	Test temp. : 40±2°C Test humidity : 90~95%RH	
	(Steady State)	Capacitance	Characteristics Class1 NP0 Class2 X8R	Change from the value before test Please contact with our sales representative.	Leave the capacitors in ambient condition for Class 1: 6~24h Class 2: 24±2h before measurement.	
		Q (Class1)	Capacitance 30pF and over 10pF and over under 30pF Under 10pF C: Rated capa	275+5/2×C min. 200+10×C min.	Reflow solder the capacitors on a P.C.Board shown in Appendix2 before testing.	
		D.F. (Class2)	200% of initial spe			
		Insulation Resistance		•		
15	Moisture Resistance	External appearance	No mechanical da	amage.	Test temp. : 40±2°C Test humidity : 90~95%RH Applied voltage : Rated voltage	
		Capacitance	Characteristics Class1 NP0 Class2 X8R X8L	Change from the value before test Please contact with our sales representative.	Test time: 500 +24,0h Charge/discharge current: 50mA or lower Leave the capacitors in ambient condition for Class 1: 6~24h Class 2: 24±2h before measurement.	
		Q (Class1) D.F. (Class2) Insulation Resistance	smaller. (As for the capac	100+10/3×C min. citance (pF)	Reflow solder the capacitors on a P.C.Board shown in Appendix2 before testing. Initial value setting (only for class 2) Voltage conditioning 《After voltage treat the capacitors under testing temperature and voltage for 1 hour,》 leave the capacitors in ambient condition for 24±2h before measurement. Use this measurement for initial value.	

No.	It	em		Perfo	rmance	Test or inspection method	
16	Life	External appearance	No mechanical damage.			Test temp. : 150±2°C Applied voltage : Please contact with	
		Capacitance	Characteristics Change from the value before test			our sales representative. Test time: 1,000 +48,0h Charge/discharge current: 50mA or	
			Class1	NP0	Please contact	lower Leave the capacitors in ambient	
			Class2	X8R X8L	with our sales representative.	condition for Class 1 : 6~24h	
						Class 2 : 24±2h before measurement	
		Q				Define a liberatura de la companya della companya de la companya de la companya della companya d	
		(Class1)	Capaci	tance	Q	Reflow solder the capacitors on a P.C.Board shown in Appendix2 before	
			30pF an	nd over	350 min.	testing.	
			10pF an under		275+5/2×C min.	Initial value setting (only for class 2)	
			Under	10pF	200+10×C min.	Voltage conditioning 《After voltage	
			C : Rate	d capa	citance (pF)	treat the capacitors under testing	
		D.F.	200% of initial spec. max.		ec. max.	temperature and voltage for 1 hour, leave the capacitors in ambient	
		(Class2)				condition for 24±2h before	
		Insulation Resistance	1,000MΩ or 50MΩ·μF min. whichever smaller. (As for the capacitors of rated voltage 16V DC and lower, 10MΩ·μF min.)			measurement. Use this measurement for initial value	

^{*}As for the initial measurement of capacitors (Class2) on number 7,11,12,13 and 14, leave capacitors at $150 \, 0,-10 \,^{\circ}$ C for 1 hour and measure the value after leaving capacitors for $24 \pm 2h$ in ambient condition.





			(Unit : mm)
Symbol Case size	а	b	С
C1005 [CC0402]	0.4	1.5	0.5
C1608 [CC0603]	1.0	3.0	1.2
C2012 [CC0805]	1.2	4.0	1.65
C3216 [CC1206]	2.2	5.0	2.0
C3225 [CC1210]	2.2	5.0	2.9
C4532 [CC1812]	3.5	7.0	3.7
C5750 [CC2220]	4.5	8.0	5.6

1. Material : Glass Epoxy(As per JIS C6484 GE4)

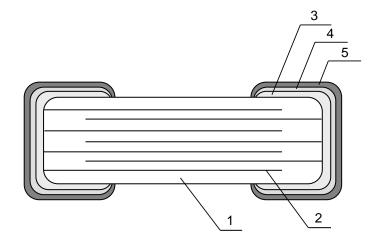
2. Thickness: Appendix 1 — 0.8mm (C1005

— 0.8mm (C1005) — 1.6mm (C1608,C2012,C3216,C3225,C4532,C5750)

: Appendix 2 — 1.6mm

Copper(Thickness:0.035mm)
Solder resist

8. INSIDE STRUCTURE AND MATERIAL



No	NAME	MATERIAL		
No.	INAIVIE	Class1	Class2	
1	Dielectric	CaZrO₃	BaTiO₃	
2	Electrode	Nicke	el (Ni)	
3		Coppe	er (Cu)	
4	Termination	Nickel (Ni)		
5		Tin (Sn)		

9. PACKAGING

Packaging shall be done to protect the components from the damage during transportation and storing, and a label which has the following information shall be attached.

- 9.1 Each plastic bag for bulk packaging contains 1000pcs. And the minimum quantity for Bulk packaging is 1000pcs.
- 9.2 Tape packaging is as per 13. TAPE PACKAGING SPECIFICATION.
 - *C1005[CC0402] type is applicable to tape packaging only.
 - 1) Inspection No.*
 - 2) TDK P/N
 - 3) Customer's P/N
 - 4) Quantity

*Composition of Inspection No.

Example
$$\underline{F}$$
 $\underline{1}$ \underline{A} $\underline{23}$ $\underline{001}$ (a) (b) (c) (d) (e)

- (a) Line code
- (b) Last digit of the year
- (c) Month and A for January and B for February and so on. (Skip I)
- (d) Inspection Date of the month.
- (e) Serial No. of the day

*Composition of new Inspection No.

(Implemented on and after May 1, 2019 in sequence)

- (a) Prefix
- (b) Line code
- (c) Last digit of the year
- (d) Month and A for January and B for February and so on. (Skip I)
- (e) Inspection Date of the month.
- (f) Serial No. of the day(00 ~ ZZ)
- (g) Suffix($00 \sim ZZ$)

10. RECOMMENDATION

As for C3225[CC1210] and larger, It is recommended to provide a slit (about 1mm width) in the board under the components to improve washing Flux. And please make sure to dry detergent up completely before.

11. SOLDERING CONDITION

As for C1005[CC0402], C3225[CC1210] and larger, reflow soldering only. For other case sizes than the above, reflow soldering is recommended.

^{*} It was shifted to the new inspection No. on and after May 2019, but the implementation timing may be different depending on shipment bases. Until the shift is completed, either current or new composition of inspection No. will be applied.

12. CAUTION

No.	Process	Condition
1	Operating Condition (Storage, Use,	1-1. Storage, Use The capacitors must be stored in an ambient temperature of 5 to 40°C with a relative humidity of 20 to 70%RH. JIS C 60721-3-1 Class 1K2 should be followed for the other climatic conditions.
	Transportation)	1) High temperature and humidity environment may affect a capacitor's solder ability because it accelerates terminal oxidization. They also deteriorate performance of taping and packaging. Therefore, SMD capacitors shall be used within 6 months. For capacitors with terminal electrodes consisting of silver or silver-palladium which tend to become oxidized or sulfurized, use as soon as possible, such as within one month after opening the bag.
		2) When capacitors are stored for a longer time period than 6 months, confirm the solderability of the capacitors prior to use. During storage, keep the minimum packaging unit in its original packaging without opening it. Do not deviate from the above temperature and humidity conditions even for a short term.
		3) Corrosive gasses in the air or atmosphere may result in deterioration of the reliability, such as poor solderability of the terminal electrodes. Do not store capacitors where they will be exposed to corrosive gas (e.g., hydrogen sulfide, sulfur dioxide, chlorine ammonia etc.)
		4) Solderability and electrical performance may deteriorate due to photochemical change in the terminal electrode if stored in direct sunlight, or due to condensation from rapid changes in humidity. The capacitors especially which use resin material must be operated and stored in an environment free of dew condensation, as moisture absorption due to condensation may affect the performance.
		5) Refer to JIS C 60721-3-1, class 1K2 for other climate conditions.
		1-2. Handling in transportation In case of the transportation of the capacitors, the performance of the capacitors may be deteriorated depending on the transportation condition. (Refer to JEITA RCR-2335C 9.2 Handling in transportation)
2	Circuit design Caution	2-1. Operating temperature 1) Upper category temperature (maximum operating temperature) is specified. It is necessary to select a capacitor whose rated temperature us higher than the operating temperature. Also, it is necessary to consider the temperature distribution in the equipment and seasonal temperature variation.
		2) Surface temperature including self heating should be below maximum operating
		temperature. Due to dielectric loss, capacitors will heat itself when AC is applied due to ESR. Especially at high frequencies, please be careful that the heat might be so extreme.
		Also, even if the surface temperature of the capacitor includes self-heating and is the maximum operating temperature or lower, excessive heating of the capacitor due to self-heating may cause deterioration of the characteristics and reliability of the capacitor.
		The self-heating temperature rise of the capacitor changes depending on the difference in heat radiation due to the mounting method to the device, the ambient temperature, the cooling method of the device and circuit board material and the design, etc.
		The load should be contained so that the self-heating temperature rise of the capacitor body in a natural convection environment at an ambient temperature of 25°C remain below 20°C.
		When using in a high-frequency circuit or a circuit in which a capacitor generates heat, such as when a high-frequency ripple current flows, pay attention to the above precautions. (Note that accurate measurement may not be possible with self-heating measurement when the equipment applies cooling other than natural convection such as a cooling fan.)
		The electrical characteristics of the capacitors will vary depending on the temperature. The capacitors should be selected and designed in taking the temperature into consideration.

No.	Process	Condition				
2	Circuit design Caution	 2-2. When overvoltage is applied Applying overvoltage to a capacitor may cause dielectric breakdown and result in a short circuit. The duration until dielectric breakdown depends on the applied voltage and the ambient temperature. 2-3. Operating voltage 1) Operating voltage across the terminals should be below the rated voltage. When AC and DC are super imposed, V0-P must be below the rated voltage. — (1) and (2) AC or pulse with overshooting, VP-P must be below the rated voltage. — (3), (4) and (5) When the voltage is started to apply to the circuit or it is stopped applying, the irregular voltage may be generated for a transit period because of resonance or switching. Be sure to use the capacitors within rated voltage containing these Irregular voltage. 				
		Voltage (1) DC voltage (2) DC+AC voltage (3) AC voltage				
		Positional Measurement (Rated voltage) 0 V _{0-P} 0				
		Voltage (4) Pulse voltage (A) (5) Pulse voltage (B)				
		Positional Measurement (Rated voltage) VP-P O VP-P O VP-P O VP-P O O VP-P O O O O O O O O O O O O O				
		Even below the rated voltage, if repetitive high frequency AC or pulse is applied, the reliability of the capacitors may be reduced.				
		The effective capacitance will vary depending on applied DC and AC voltages. The capacitors should be selected and designed in taking the voltages into consideration.				
		Abnormal voltage (surge voltage, static electricity, pulse voltage, etc.) shall not exceed the rated voltage.				
		5) When capacitors are used in a series connection, it is necessary to add a balancing circuit such as voltage dividing resistors in order to avoid an imbalance in the voltage applied to each capacitor.				
		2-4. Frequency When the capacitors (Class 2) are used in AC and/or pulse voltages, the capacitors may vibrate themselves and generate audible sound.				

No.	Process	Condition					
3	Designing P.C.board	 The amount of solder at the terminations has a direct effect on the reliability of the capacitors. The greater the amount of solder, the higher the stress on the chip capacitors, and the more likely that it will break. When designing a P.C.board, determine the shape and size of the solder lands to have proper amount of solder on the terminations. Avoid using common solder land for multiple terminations and provide individual solder land for each terminations. Size and recommended land dimensions. 					
			Chip o	apacitors			
		Solder land Solder resist					
		Reflow soldering				(Unit : mm)	
		Case size Symbol	C1005 [CC0402]	C1608 [CC0603]	C2012 [CC0805]	C3216 [CC1206]	
		A	0.3 ~ 0.5	0.6 ~ 0.8	0.9 ~ 1.2	2.0 ~ 2.4	
		В	0.35 ~ 0.45	0.6 ~ 0.8	0.7 ~ 0.9	1.0 ~ 1.2	
		C	0.4 ~ 0.6	0.6 ~ 0.8	0.9 ~ 1.2	1.1 ~ 1.6	
		Case size Symbol	C3225 [CC1210]	C4532 [CC1812]	C5750 [CC2220]		
		A	2.0 ~ 2.4	3.1 ~ 3.7	4.1 ~ 4.8		
		B C	1.0 ~ 1.2	1.2 ~ 1.4 2.4 ~ 3.2	1.2 ~ 1.4 4.0 ~ 5.0		
			1.9 ~ 2.5	2.4 ~ 3.2	4.0 ~ 5.0		
		Flow soldering (Un	recommend)		(Unit : m	nm)	
		Case size Symbol	C1608 [CC0603]	C2012 [CC0805]	C3216 [CC120		
		A	0.7 ~ 1.0	1.0 ~ 1.3	2.1 ~ 2.	5	
		В	0.8 ~ 1.0	1.0 ~ 1.2	1.1 ~ 1.	3	
		C	0.6 ~ 0.8	0.8 ~ 1.1	1.0 ~ 1.	3	
				I			

No.	Process		Condition	
3	Designing P.C.board	4) Recommende	d chip capacitors layout is as follo	owing.
			Disadvantage against bending stress	Advantage against bending stress
		Mounting face	Perforation or slit	Perforation or slit
			Break P.C.board with mounted side up.	Break P.C.board with mounted side down.
			Mount perpendicularly to perforation or slit	Mount in parallel with perforation or slit
		Chip arrangement (Direction)	Perforation or slit	Perforation or slit
			Closer to slit is higher stress	Away from slit is less stress
		Distance from slit	$\begin{array}{c c} \mathcal{Q}_1 \\ \vdots \\ \vdots \\ \mathcal{Q}_1 < \mathcal{Q}_2 \end{array})$	Q_2 \vdots \vdots \vdots \vdots $(Q_1 < Q_2)$

Condition No. **Process** 5) Mechanical stress varies according to location of chip capacitors on the P.C.board. 3 Designing P.C.board E Perforation 00000 00000 В Stress force A>B>EA>D>ESlit A > CWhen dividing printed wiring boards, the intensities of mechanical stress applied to capacitors are different according to each dividing method in the order of : Push-back < Slit < V-groove < Perforation. Therefore consider not only position of capacitors, but also the way of the dividing the printed wiring boards. 6) Layout recommendation Use of common Use of common Soldering with Example solder land with solder land chassis other SMD Lead wire Chassis Solder land Chip Excessive solder Solder Need to avoid Excessive solder PCB Adhesive Solder land Solder Missing solder Lead wire Solder resist Solder resist Recommendation Solder resist $Q_2 > Q_1$

No.	Process			Condition			
4	Mounting	d-1. Stress from mounting head If the mounting head is adjusted too low, it may induce excessive stress in the capacitors to result in cracking. Please take following precautions.					
		 Adjust the bottom dead center of the mounting head to reach on the P.C.bo surface and not press it. 					
		2) Adjust the mour	nting head p	ressure to be 1 to 3N	I of static weight.		
		 To minimize the impact energy from mounting head, it is important to provide support from the bottom side of the P.C.board. See following examples. 					
			Not recommended Recom				
		Single-sided mounting		Crack	Support pin is not to be underneath the capacitor.		
		Double-sides mounting	Solde	er Crack	Support pin		
		capacitors to caus	When the centering jaw is worn out, it may give mechanical impact on the capacitors to cause crack. Please control the close up dimension of the centering jaw and provide sufficient preventive maintenance and replacement of it.				
			<u></u>	**************************************	b		
		=	C C				
			Example : (C2012 [CC0805], C3	216 [CC1206]		
		-	a	0.2mm m			
		-	b	70 ~ 100 _k	um		
			С	Do not touch the	solder land		

No.	Process	Condition				
5	Soldering	 5-1. Flux selection Flux can seriously affect the performance of capacitors. Confirm the following to select the appropriate flux. 1) It is recommended to use a mildly activated rosin flux (less than 0.1wt% chlorine). Strong flux is not recommended. 2) Excessive flux must be avoided. Please provide proper amount of flux. 3) When water-soluble flux is used, enough washing is necessary. 				
	3) Whe	5-2. Recommended soldering profile: Reflow method Refer to the following temperature profile at Reflow soldering. Reflow soldering Soldering Preheating Natural cooling Preheating Peak Temp time Reflow soldering is recommended for C1608,C2012,C3216 types, but only reflow soldering is allowed for other case sizes. 5-3. Recommended soldering peak temp and peak temp duration for Reflow soldering				
		Pb free solder is recommended, but if Sn-37Pb must be used, refer to below. Temp./Duration Reflow soldering				
		Solder Peak temp(°C) Duration(sec.)				
		Lead Free Solder 260 max. 10 max.				
		Sn-Pb Solder 230 max. 20 max.				
		Recommended solder compositions Lead Free Solder : Sn-3.0Ag-0.5Cu				

No.	Process	Condition				
5	5 Soldering 5-4. Soldering profile : Flow method (Unrecommend) Refer to the following temperature profile at Flow soldering.					
		 	Pr∈	Flow soldering Soldering Natu	ral cooling	
		Peak Temp (O°) dmar	Ove	er 60 sec. Over Peak Temp time	er 60 sec.	
		Reflow soldering	is rec	ommended for C160	8,C2012,C	3216 types.
		5-5. Recommended soldering Pb free solder is recommended.	ng pea	ık temp and peak tem	np duration	for Flow soldering
		Temp./Durat	tion Flow soldering		dering	
		Solder		Peak temp(°C)	Duratio	n(sec.)
		Lead Free Solo	der	260 max.	5 m	ax.
		Sn-Pb Solder		250 max.	3 m	ax.
		Recommended solder c Lead Free Solder : Sn-	3.0Ag			
		5-6. Avoiding thermal shock1) Preheating condition				
		Soldering		Case size		Temp. (°C)
		Reflow soldering	C1005(CC0402),C1608(CC0603), C2012(CC0805),C3216(CC1206)		206)	ΔT ≦ 150
			C3225(CC1210), C4532(CC1812), C5750(CC2220)		1812),	ΔT ≦ 130
		Flow soldering		8(CC0603),C2012(CC0 6(CC1206)	9805),	ΔT ≦ 150
		Cooling condition Natural cooling using ai cleaning, the temperatu				

No.	Process	Condition				
5	Soldering	5-7. Amount of solder Excessive solder will induce higher tensile force in chip capacitors when temperature changes and it may result in chip cracking. In sufficient solder may detach the capacitors from the P.C.board.				
		Excessive solder Higher tensile force in chip capacitors to cause crack				
		Adequate Maximum amount Minimum amount				
		Insufficient solder Low robustness may cause contact failure or chip capacitors come off the P.C.board.				
		 5-8. Sn-Zn solder Sn-Zn solder affects product reliability. Please contact TDK in advance when utilize Sn-Zn solder. 5-9. Countermeasure for tombstone The misalignment between the mounted positions of the capacitors and the land patterns should be minimized. The tombstone phenomenon may occur especially the capacitors are mounted (in longitudinal direction) in the same direction of the reflow soldering. (Refer to JEITA RCR-2335C Annex A (Informative), Recommendations to prevent the tombstone phenomenon.) 				

No.	Process		Condition		
6	Solder repairing	(also called a "blower") ra			
		capacitor compared to understand capacitor uniformly with stress caused by quick Moreover, where ultrassized ircuit board, reworking	heater may suppress the occurrence of cracks in the using a soldering iron. A spot heater can heat up a a small heat gradient which leads to lower thermal heating and cooling or localized heating. I mall capacitors are mounted close together on a printed with a spot heater can eliminate the risk of direct contact dering iron and a capacitor.		
		2) Rework condition If the blower nozzle of a spot heater is too close to a capacitor, a crack capacitor may occur due to heat stress. Below are recommendations for such an occurrence. Keep more than 5mm between a capacitor and a spot heater nozzle. The blower temperature of the spot heater shall be lower than 400°C. The airflow shall be set as weak as possible. The diameter of the nozzle is recommended to be 2mm(one-outlet type is standard and common. Duration of blowing hot air is recommended to be 10s or less for C1608 C2012(CC0805) and C3216(CC1206), and 30s or less for C3225(CC12 C4532(CC1812) and C5750(CC2220), considering surface area of the and melting temperature of solder. The angle between the nozzle and the capacitor is recommended to be 45degrees in order to work easily and to avoid partial area heating. As is the case when using a soldering iron, preheating reduces thermal capacitors and improves operating efficiency.			
		· Recommended rework	condition (Consult the component manufactures for details.)		
		Distance from nozzle	5mm and over		
		Nozzle angle	45degrees		
		Nozzle temp.	400°C and less		
		Airflow	Set as weak as possible (The airflow shall be the minimum value necessary for solder to melt in the conditions mentioned above.)		
		Nozzle diameter	ø2mm (one-outlet type)		
		Blowing duration	10s and less (C1608[CC0603], C2012[CC0805], C3216[CC1206]) 30s and less (C3225[CC1210], C4532[CC1812], C5750[CC2220])		
		Excess solder causes m in cracks. Insufficient s	One-outlet type nozzle Angle: 45degrees d be suitable to from a proper fillet shape. echanical and thermal stress on a capacitor and results older causes weak adherence of the capacitor to the lt in detachment of a capacitor and deteriorate reliability		
		See the example of app	propriate solder fillet shape for 5-7.Amount of solder.		

No.	Process				Condition		
6	Solder repairing	6-2. Solder repair by	solder	iron			
		solder land size. However, heat sl Please make sur	of solo The h hock m	ler iron vigher the hay caus	ovaries by its type, etip temperature, se a crack in the confere soldering recommended	the quicker the hip capacitors. and keep the p	e operation.
		Manual soldering (Solder iron)					
		Peak Temp O AT Preheating 3sec. (As short as possible) Recommended solder iron condition (Sn-Pb Solder and Lead Free Solder)				Eros Osldon)	
		Recommended Case size		r iron coi p. (°C)	Duration (Sn-Pb So	Wattage (W)	Shape (mm)
		C1005(CC0402) C1608(CC0603) C2012(CC0805) C3216(CC1206)		max.	3 max.	20 max.	Ø3.0 max.
		C3225(CC1210) C4532(CC1812) C5750(CC2220)	280	max.			
		* Please preheat the shock.	chip ca	apacitors	with the conditio	n in 6-3 to avoi	d the thermal
		 Direct contact of the soldering iron with ceramic dielectric of chip capacitors may cause crack. Do not touch the ceramic dielectric and the terminations by solder iron. 					
		6-3. Avoiding thermal shock					
		Preheating condition					
		Soldering)	04555	Case size		Temp. (°C)
	Manual soldering C1005(CC0402),C1608(CC0603), C2012(CC0805),C3216(CC1206) C2025(CC1210),C4523(CC1812)			C1206)	ΔT ≦ 150		
1 (3225(001210) (24532(001812) 1				ΔT ≦ 130			

No.	Process	Condition
7	Cleaning	If an unsuitable cleaning fluid is used, flux residue or some foreign articles may stick to chip capacitors surface to deteriorate especially the insulation resistance.
		2) If cleaning condition is not suitable, it may damage the chip capacitors.
		2)-1. Insufficient washing
		(1) Terminal electrodes may corrode by Halogen in the flux.
		(2) Halogen in the flux may adhere on the surface of capacitors, and lower the insulation resistance.
		(3) Water soluble flux has higher tendency to have above mentioned problems (1) and (2).
		2)-2. Excessive washing
		When ultrasonic cleaning is used, excessively high ultrasonic energy output can affect the connection between the ceramic chip capacitor's body and the terminal electrode. To avoid this, following is the recommended condition.
		Power: 20 W/2 max.
		Frequency : 40 kHz max.
		Washing time : 5 minutes max.
		2)-3. If the cleaning fluid is contaminated, density of Halogen increases, and it may
		bring the same result as insufficient cleaning.
8	Coating and	1) When the P.C.board is coated, please verify the quality influence on the product.
	molding of the P.C.board	Please verify carefully that there is no harmful decomposing or reaction gas emission during curing which may damage the chip capacitors.
		3) Please verify the curing temperature.

No.	Process	Condition			
9	Handling after chip mounted Caution	2) Printed circuit board of proper tooling. Printed cropping jig as shown prevent inducing med (1)Example of a boar Recommended exclose to the cropping the capacitor is countrecommended of the pushing direction.	e chip capacitors may crack. end eropping should not be carried circuit board cropping should in the following figure or a chanical stress on the board. In cropping jig cample: The board should be not jig so that the board is not mpressive. example: If the pushing point	Twist d out by hand, but by using the ld be carried out using a board a board cropping apparatus to e pushed from the back side, the bent and the stress applied to is far from the cropping jig and the board, large tensile stress is	
		Outline of jig Printed circuit board Slot Outline of jig V-groove Board cropping jig	Recommended Printed circuit board Components Load point V-groove Slot	Unrecommended Load point Printed circuit board V-groove Slot	

No.	Process			Conditio	n			
9	Handling after chip mounted	An ou top a V-gro Unred	ple of a board crutline of a printed nd bottom blades boves on printed commended examen, right and left, citor.	d circuit board c s are aligned wi circuit board wh mple: Misalignn	ropping machi ith one anothe nen cropping the nent of blade p	r along the lines ne board. position betweel	s with the	
			Outline of mac	hine	Princip	le of operation		
			Prin	Top blade Print	ted circuit board	op blade 0 ttom blade		
					Cro	ss-section diagra		
		Printed circuit board Top				blade		
					V-groo	V-groove Bottom blade		
		Тс		Unrecommended				
			Recommended	Top-bottom	Left-right	Front-rear		
			Top blade	misalignment	misalignment	misalignment		
			Board	Top blade	Top blade	Top blade		
			Bottom blade	Bottom blade	Bottom blade	Bottom blade		
				Dottom blade	Dottom blade	Dottom blade		
		to be adju	ectional check of the steel higher for feather the P.C.board, it ons off. Please ac	ear of loose cor may crack the	ntact. But if the chip capacitor	pressure is exc s or peel the	cessive	
		Item	Not recon	nmended	Re	commended		
				Termination		Support pi	n	
		Doord		peeling		A M		
		Board bending		Check pin		← Chec	k pin	

No.	Process	Condition
10	Handling of loose chip capacitors	If dropped the chip capacitors may crack. Once dropped do not use it. Especially, the large case sized chip capacitors are tendency to have cracks easily, so please handle with care. Crack Floor
		Piling the P.C.board after mounting for storage or handling, the corner of the P.C. board may hit the chip capacitors of another board to cause crack. Crack Crack
11	Capacitance aging	The capacitors (Class 2) have aging in the capacitance. They may not be used in precision time constant circuit. In case of the time constant circuit, the evaluation should be done well.
12	Estimated life and estimated failure rate of capacitors	As per the estimated life and the estimated failure rate depend on the temperature and the voltage. This can be calculated by the equation described in JEITA RCR-2335C Annex F (Informative) Calculation of the estimated lifetime and the estimated failure rate (Voltage acceleration coefficient: 3 multiplication rule, Temperature acceleration coefficient: 10°C rule) The failure rate can be decreased by reducing the temperature and the voltage but they will not be guaranteed.

No.	Process	Condition
13	Caution during operation of equipment	A capacitor shall not be touched directly with bare hands during operation in order to avoid electric shock. Electric energy held by the capacitor may be discharged through the human body when touched with a bare hand. Even when the equipment is off, a capacitor may stay charged. The capacitor should be handled after being completely discharged using a resistor.
		2) The terminals of a capacitor shall not be short-circuited by any accidental contact with a conductive object. A capacitor shall not be exposed to a conductive liquid such as an acid or alkali solution. A conductive object or liquid, such as acid and alkali, between the terminals may lead to the breakdown of a capacitor due to short circuit.
		 Confirm that the environment to which the equipment will be exposed during transportation and operation meets the specified conditions. Do not to use the equipment in the following environments. Environment where a capacitor is spattered with water or oil Environment where a capacitor is exposed to direct sunlight Environment where a capacitor is exposed to Ozone, ultraviolet rays or radiation Environment where a capacitor exposed to corrosive gas(e.g. hydrogen sulfide, sulfur dioxide, chlorine. ammonia gas etc.) Environment where a capacitor exposed to vibration or mechanical shock exceeding the specified limits. Atmosphere change with causes condensation
14	Others Caution	The products listed on this specification sheet are intended for use in general electronic equipment (AV equipment, telecommunications equipment, home appliances, amusement equipment, computer equipment, personal equipment, office equipment, measurement equipment, industrial robots) under a normal operation and use condition. The products are not designed or warranted to meet the requirements of the applications listed below, whose performance and/or quality require a more stringent level of safety or reliability, or whose failure, malfunction or trouble could cause serious damage to society, person or property. Please understand that we are not responsible for any damage or liability caused by use of the products in any of the applications below or for any other use exceeding the range or conditions set forth in this specification sheet. If you intend to use the products in the applications listed below or if you have special requirements exceeding the range or conditions set forth
		in this specification, please contact us. (1) Aerospace/Aviation equipment (2) Transportation equipment (cars, electric trains, ships, etc.) (3) Medical equipment (Excepting Pharmaceutical Affairs Law classification Class1, 2) (4) Power-generation control equipment (5) Atomic energy-related equipment (6) Seabed equipment (7) Transportation control equipment (8) Public information-processing equipment (9) Military equipment (10) Electric heating apparatus, burning equipment (11) Disaster prevention/crime prevention equipment (12) Safety equipment (13) Other applications that are not considered general-purpose applications When designing your equipment even for general-purpose applications, you are kindly requested to take into consideration securing protection circuit/device or

13. TAPE PACKAGING SPECIFICATION

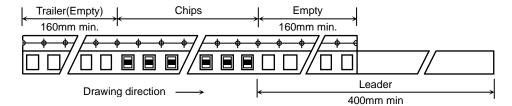
1. CONSTRUCTION AND DIMENSION OF TAPING

1-1. Dimensions of carrier tape

Dimensions of paper tape shall be according to Appendix 3, 4.

Dimensions of plastic tape shall be according to Appendix 5, 6.

1-2. Bulk part and leader of taping

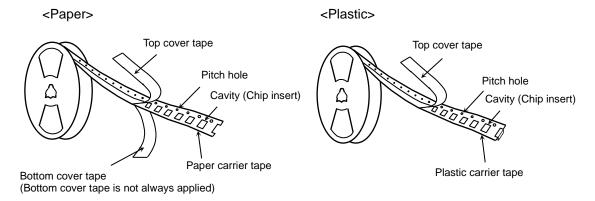


1-3. Dimensions of reel

Dimensions of Ø178 reel shall be according to Appendix 7, 8.

Dimensions of Ø330 reel shall be according to Appendix 9, 10.

1-4. Structure of taping



2. CHIP QUANTITY

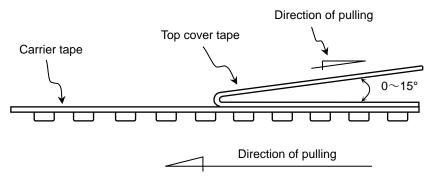
Please refer to detail page on TDK web.

3. PERFORMANCE SPECIFICATIONS

3-1. Fixing peeling strength (top tape)0.05N < Peeling strength < 0.7N

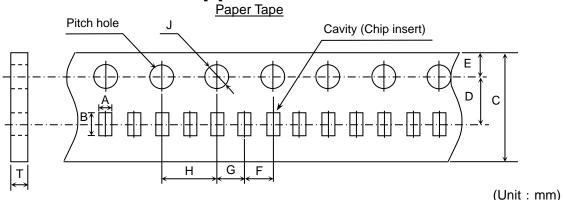
Carrier tape Carrier tape Direction of cover tape pulling Top cover tape Direction of pulling Paper tape should not adhere to top cover tape when pull the cover tape.

<Plastic>



- 3-2. Carrier tape shall be flexible enough to be wound around a minimum radius of 30mm with components in tape.
- 3-3. The missing of components shall be less than 0.1%
- 3-4. Components shall not stick to fixing tape.
- 3-5. When removing the cover tape, there shall not be difficulties by unfitting clearance gap, burrs and crushes of cavities. Also the sprocket holes shall not be covered by absorbing dust into the suction nozzle.





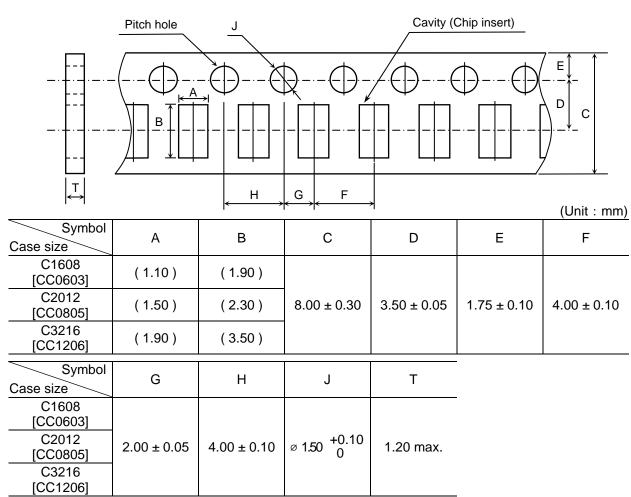
						(01111.11111)
Symbol Case size	Α	В	С	D	E	F
C1005 [CC0402]	(0.65)	(1.15)	8.00 ± 0.30	3.50 ± 0.05	1.75 ± 0.10	2.00 ± 0.05
Symbol	0	1.1		т	•	

Symbol Case size	G	Н	J	Т
C1005 [CC0402]	2.00 ± 0.05	4.00 ± 0.10	ø 1.50 ^{+0.10}	0.60±0.05

) Reference value.

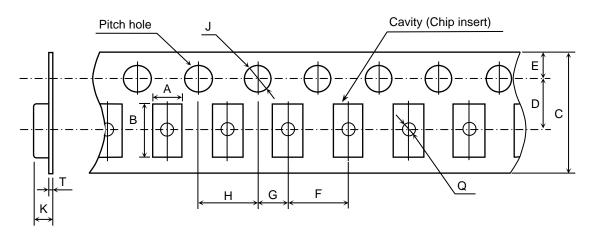
Appendix 4

Paper Tape



() Reference value.

Plastic Tape



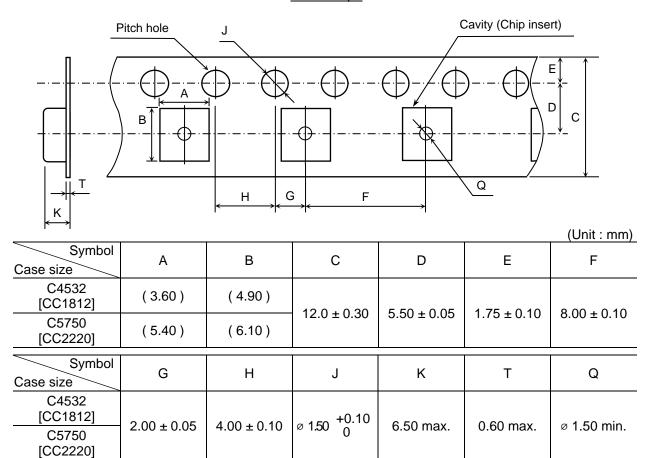
						(Unit : mm)
Symbol Case size	А	В	С	D	Е	F
C2012 [CC0805]	(1.50)	(2.30)	0.00 . 0.20	2.50 . 0.05		
C3216 [CC1206]	(1.90)	(3.50)	8.00 ± 0.30 *12.0 ± 0.30	3.50 ± 0.05 *5.50 ± 0.05	1.75 ± 0.10	4.00 ± 0.10
C3225 [CC1210]	(2.90)	(3.60)	12.0 ± 0.50	3.30 ± 0.03		
Symbol Case size	G	Н	J	К	Т	Q
C2012 [CC0805]				2.50 max.		
C3216 [CC1206]	2.00 ± 0.05	4.00 ± 0.10	ø 1.50 ^{+0.10}	2.50 IIIax.	0.60 max.	ø 0.50 min.
C3225 [CC1210]				3.40 max.		

() Reference value.

* Applied to thickness, 2.5mm products.

Exceptionally no hole in the cavity is applied. Please inquire if hole in cavity is mandatory.

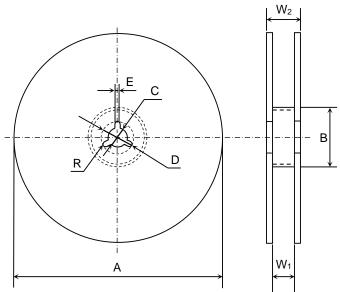
Plastic Tape



⁾ Reference value.

Exceptionally no hole in the cavity is applied. Please inquire if hole in cavity is mandatory.

<u>Dimensions of reel</u> (Material : Polystyrene) C1005, C1608, C2012, C3216, C3225

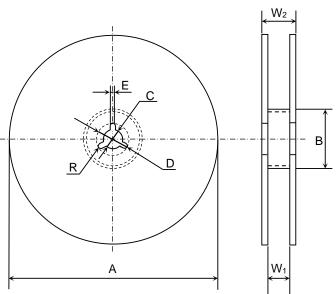


	l			1		(Unit: mm)
Symbol	А	В	С	D	E	W ₁
Dimension	∅ 178 ± 2.0	Ø 60 ± 2.0	Ø 13 ± 0.5	ø 21 ± 0.8	2.0 ± 0.5	9.0 ± 0.3

Symbol	W_2	R		
Dimension	13.0 ± 1.4	1.0		

Appendix 8

<u>Dimensions of reel</u> (Material : Polystyrene) C3225(2.5mm thickness products), C4532, C5750

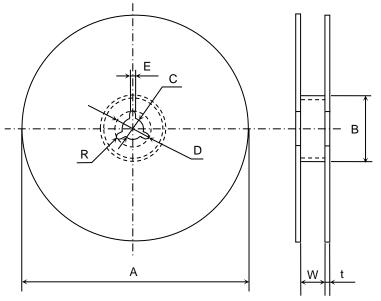


 Symbol
 A
 B
 C
 D
 E
 W₁

 Dimension
 Ø 178 ± 2.0
 Ø 60 ± 2.0
 Ø 13 ± 0.5
 Ø 21 ± 0.8
 2.0 ± 0.5
 13.0 ± 0.3

Symbol	W ₂	R
Dimension	17.0 ± 1.4	1.0

<u>Dimensions of reel</u> (Material : Polystyrene) C1005, C1608, C2012, C3216, C3225

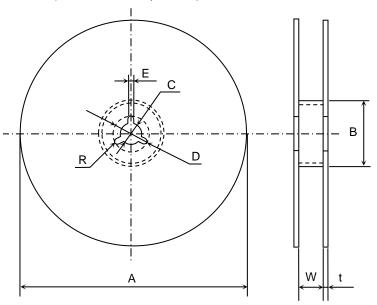


	ı			I	l II	(Unit: mm)
Symbol	Α	В	С	D	E	W
Dimension	ø 382 max. (Nominal ø 330)	ø 50 min.	ø 13 ± 0.5	Ø 21 ± 0.8	2.0 ± 0.5	10.0 ± 1.5

Symbol	t	R
Dimension	2.0 ± 0.5	1.0

Appendix 10

<u>Dimensions of reel</u> (Material : Polystyrene) C3225(2.5mm thickness products), C4532, C5750



				7		(Unit : mm)
Symbol	Α	В	С	D	Е	W
Dimension	ø 382 max. (Nominal ø 330)	ø 50 min.	∅ 13 ± 0.5	∅ 21 ± 0.8	2.0 ± 0.5	14.0 ± 1.5

Symbol	t	R
Dimension	2.0 ± 0.5	1.0